

# Engineering/Process Change Notice

#### ECN/PCN No.: 4461

For Manufacturer				
<b>Product Description:</b> Ceramic SMD Crystal Oscillator	Abracon Part Number EH35 Series	er / Part Series:	<ul> <li>□ Documentation only</li> <li>○ ECN</li> <li>○ EOL</li> </ul>	⊠ Series □ Part Number
Affected Revision: Rev. F 02/27/2015	New Revision:	)L	Application:	□ Safety ⊠ Non-Safety
Prior to Change:				
After Change: EOL				
Cause/Reason for Change: Discontinuation of manufacturing capabilit	Σy			
	Chan	ge Plan		
Effective Date: 11/15/2022	Additional Remarks: N/A			
Change Declaration: N/A				
Issued Date: 11/15/22	Issued By: Conor Healey		Issued Department: Engineering	
Approval: Thomas Culhane Engineering Director	Approval: Reuben Quintanilla Quality Director		Approval: Ying Huang Purchasing Director	
	For Abrac	on EOL only		
Last Time Buy (if applicable): 02-15-2023 Based upon material availability, contact Abracon for details		Alternate Part Number / Part Series: FO5HS (15 pF)		
Additional Approval:	Additional Approval:		Additional Approval:	
Customer Approval (If Applicable)				
Qualification Status:				
□ Approved □ Not accepted Note: It is considered approved if there is no feedback from the customer 1 month after ECN/PCN is released.				
Customer Part Number:		Customer Project:		
Company Name:	Company Representa	ative:	Representative Signature:	:
Customer Remarks:				

Form #7020 | Rev. G | Effective: 02/22/2021 |

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# EH35 Series



### REGULATORY COMPLIANCE

Lead Free	EU RoHS	<b>China RoHS</b>	REACH
$\bigotimes$	2011/65 + 2015/863	<b>O</b>	SVHC
COMPLIANT	COMPLIANT	COMPLIANT	COMPLIANT



#### **ITEM DESCRIPTION**

Quartz Crystal Clock Oscillators XO (SPXO) HCMOS/TTL (CMOS) 5.0Vdc 4 Pad 3.2mm x 5.0mm Ceramic Surface Mount (SMD)

ELECTRICAL SPECIFICATIONS		
Nominal Frequency	1MHz to 155.52MHz	
Frequency Tolerance/Stability	Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, 1st Year Aging at 25°C, Shock, and Vibration ±100ppm Maximum ±20ppm Maximum ±25ppm Maximum ±50ppm Maximum	
Aging at 25°C	±5ppm/year Maximum	
Operating Temperature Range	0°C to +70°C -40°C to +85°C	
Supply Voltage	5.0Vdc ±10%	
Input Current	No Load 50mA Maximum	
Output Voltage Logic High (V <sub>он</sub> )	IOH = -16mA 2.4Vdc Minim <mark>um wit</mark> h TTL Load, Vdd-0.4Vdc Minimum with H <mark>CMOS L</mark> oad	
Output Voltage Logic Low (V₀∟)	IOL = +16mA 0.4Vdc Maxim <mark>um wit</mark> h TTL Load, 0.5Vdc Maximum with HCMO <mark>S Load</mark>	
Rise/Fall Time	Measured at 0. <mark>8Vdc t</mark> o 2.0Vdc with TTL Load or at 20% to 80% <mark>of wav</mark> eform with HCMOS Load 6nSec Maximum over Nominal Frequency of 1MHz to 70MHz 4nSec Maximum over Nominal Frequency of 70.000001MHz to 155.52MHz	
Duty Cycle	50 ±10(%) (Measured at 1.4Vdc with TTL Load or at 50% of waveform with HCMOS Load over Nominal Frequency range of 1MHz to 70MHz; Measured at 50% of waveform with TTL Load or with HCMOS Load over Nominal Frequency range of 70.000001MHz to 155.52MHz) 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)	
Load Drive Capability	10TTL Load or 50pF HCMOS Load Maximum over Nominal Frequency of 1MHz to 70MHz 5TTL Load or 15pF HCMOS Load Maximum over Nominal Frequency of 70.000001MHz to 155.52MHz	
Output Logic Type	CMOS	
Pin 1 Connection	Tri-State (Disabled Output: High Impedance)	
Tri-State Input Voltage (Vih and Vil)	+2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.	
Absolute Clock Jitter	±250pSec Maximum, ±100pSec Typical	
One Sigma Clock Period Jitter	±50pSec Maximum, ±30p <mark>Sec Typic</mark> al	
Start Up Time	10mSec Maximum	
Storage Temperature Range	-55°C to +125°C	

## **EH35 Series**



#### PART NUMBERING GUIDE





#### **MECHANICAL DIMENSIONS**





#### OUTPUT WAVEFORM & TIMING DIAGRAM





### TEST CIRCUIT FOR TTL OUTPUT



**Note 1:** An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass Capacitor close to the package ground and VDD pin is required.

- **Note 2:** A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value CL includes sum of all probe and fixture capacitance.
- Note 4: Resistance value RL is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.
- Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



### TEST CIRCUIT FOR CMOS OUTPUT



# **EH35** Series



#### **TAPE & REEL DIMENSIONS**

Quantity per Reel: 1,000 Units All Dimensions in Millimeters

Compliant to EIA-481





### **RECOMMENDED SOLDER REFLOW METHOD**



HIGH TEMPERATURE INFRARED/CONVECTION				
$T_s$ MAX to $T_L$ (Ramp-up Rate)	3°C/Second Maximum			
Preheat				
- Temperature Minimum (T <sub>s</sub> MIN)	150°C			
- Temperature Typical (T <sub>s</sub> TYP)	175°C			
- Temperature Maximum(T <sub>s</sub> MAX)				
- Time (t <sub>s</sub> )	60 - 180 Seconds			
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/Second Maximum			
Time Maintained Above:				
- Temperature (T <sub>L</sub> )	217°C			
- Time (t <sub>L</sub> )	60 - 150 Seconds			
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum			
Target Peak Temperature(T <sub>P</sub> Target)	250°C +0/-5°C			
Time within 5°C of actual peak (t <sub>p</sub> )	20 - 4 <mark>0 Seconds</mark>			
Ramp-down Rate	6°C/Second Maximum			
Time 25°C to Peak Temperature (t)	8 Minutes Maximum			
Moisture Sensitivity Level	Level 1			
Additional Notes	Temperatures shown are applied to body of device.			

#### High Temperature Manual Soldering

260°C Maximum for 5 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)



### **RECOMMENDED SOLDER REFLOW METHOD**



LOW TEMPERATURE INFRARED/CONVECTION		
T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/Second Maximum	
Preheat		
- Temperature Minimum (T <sub>S</sub> MIN)	N/A	
- Temperature Typical (T <sub>s</sub> TYP)	150°C	
- Temperature Maximum(T <sub>s</sub> MAX)	N/A	
- Time (t <sub>s</sub> )	60 - 120 Seconds	
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C / Second Maximum	
Time Maintained Above:		
- Temperature (T <sub>L</sub> )	150°C	
- Time (t <sub>L</sub> )	200 Seconds Maximum	
Peak Temperature (T <sub>P</sub> )	240°C	
Target Peak Temperature(T <sub>P</sub> Target)	240°C Maximum 2 Times / 230°C Maximum 1Time	
Time within 5°C of actual peak (t <sub>P</sub> )	10 Seconds Maximum 2 Times / 80 Seconds Maximum 1 Time	
Ramp-down Rate	5°C / Second Maximum	
Time 25°C to Peak Temperature (t)	N/A	
Moisture Sensitivity Level	Level 1	
Additional Notes	Temperatures shown are applied to body of device.	

#### Low Temperature Manual Soldering

185°C Maximum for 10 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)